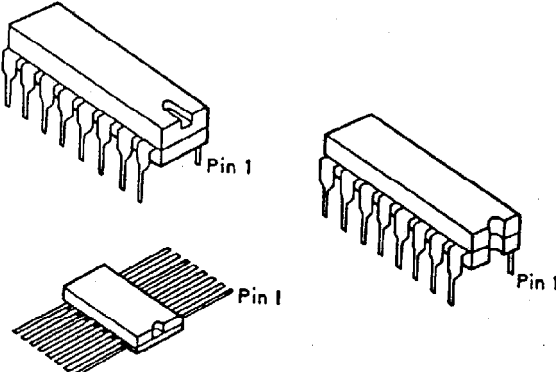


BRITISH STANDARDS INSTITUTION 2 PARK STREET, LONDON. W1A 2BS	BS CECC 90103 - 131 ISSUE 1 NOVEMBER 1981  Page 1 of 19 pages
Specification available from:- AS SHOWN IN PD 9002 AND CECC 00 200 AND ELECTRONIC COMPONENTS OF ASSESSED QUALITY DETAIL SPECIFICATION IN ACCORDANCE WITH: BS CECC 90 000 : 1976 BS CECC 90 100 : 1977	MANUFACTURERS TYPE NUMBER 54LS399 64LS399 74LS399 84LS399 SEE PD 9002 AND CECC 00 200 For ordering information see clause 1
Outline not to scale: Isometric projection Marking information see clause 1  Refer to IEC 191-1-50a (type A50C) Dual-in-Line (plastic or ceramic) refer to Appendix A1.3 Flatpack (metal or ceramic)	QUADRUPLER 2-INPUT MULTIPLEXERS WITH STORAGE TYPICAL CONSTRUCTION SILICON MONOLITHIC BIPOLAR TTL-LOW-POWER SCHOTTKY ASSESSMENT LEVELS R, S, T AND V

1. Type description

1.1 Truth table (see page 2)

Refer to Qualified Products List PD 9002 and/or CECC 00 200 for details of manufacturers approved to this specification

1.1 Truth table (contd)

INPUTS		OUTPUTS			
WORD SELECT	CLOCK	Q _A	Q _B	Q _C	Q _D
L	↑	a1	b1	c1	d1
.H	↑	a2	b2	c2	d2
X	L	Q _{AO}	Q _{BO}	Q _{CO}	Q _{DO}

H = High level

L = Low level

X = Logic level irrelevant

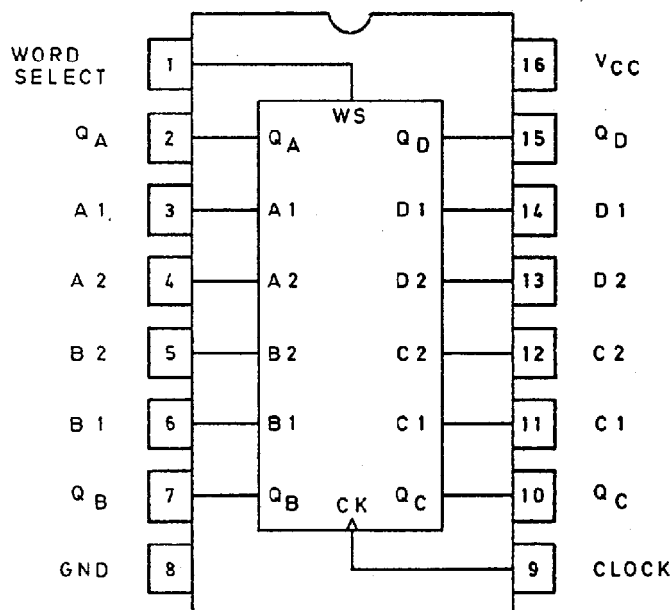
↑ = Low to High transition

a...d = The level of steady level inputs at inputs A through D

Q_{AO} - Q_{DO} = The level of Q_A etc., before the indicated steady level input conditions were established

1.2 Terminal identification, type designation and marking

1.2.1 Terminal identification



Quadruple 2-input multiplexers with storage

1.2.2 Type designation

TEMPERATURE RANGE	PACKAGE		
	Ceramic Dual-in-Line	Plastic Dual-in-Line	Ceramic Flatpack
0 + 70	74LS399J	N	W
-25 + 85	84LS399J		
-40 + 85	64LS399J		
-55 +125	54LS399J		

1.2.3 Marking

Each integrated circuit shall bear the following markings:

- (1) Terminal identification
- (2) Type designation
- (3) Date code
- (4) Factory identification code (unless derived from trademark)
- (5) Manufacturers trade name or mark
- (6) Mark of conformity (unless a certificate of conformity is used)

1.3 Ordering information

Orders for these integrated circuits shall contain the following minimum information:

Manufacturers integrated circuit type designation, screening procedures and assessment levels as detailed to this CECC specification number.

(For details of screening procedures see Appendix A1.1)

2. Limiting conditions of use (not for inspection purposes)

2.1	Maximum continuous supply voltage	V_{CC}	-0,5V +7,0V
2.2	Maximum input voltages		
2.2.1	Maximum input voltage	V_I	-0,5V +7,0V
2.2.2	Maximum input voltage between multiple emitter transistor inputs	V_{II}	+5,5V

- 2.3 Minimum and maximum operating ambient temperatures $T_{amb}(^{\circ}\text{C})$ min. -55 -40 0 -25
max. +125 +85 +70 +85
- 2.4 Minimum and maximum storage temperatures $T_{stg}(^{\circ}\text{C})$ min. -65 (All types)
max. +150

3. Recommended operating conditions and associated characteristics (not for inspection purposes)

3.1 Recommended operating conditions

These apply over the operating ambient temperature range unless otherwise stated.

Description	Symbol	Type	Value	Unit
Positive supply voltage range	V_{CC}	54LS 64/74/84LS	4,5 - 5,5 4,75 - 5,25	V V
Minimum value of High level input voltage	V_{IHB}	All types	2,0	V
Maximum value of High level input voltage	V_{IHA}	All types	5,5	V
Minimum value of Low level input voltage	V_{ILB}	All types	-0,3	V
Maximum value of Low level input voltage	V_{ILA}	54LS 64/74/84LS	0,7 0,8	V V
Maximum value of Low level output current for each output	I_{OLA}	54LS 64/74/84LS	4,0 8,0	mA mA
Maximum value of output current for each output at V_{OH}	I_{OHA}	All types	-400,0	μA
D.C. noise margin at Low level ($V_{ILA} - V_{OLA}$)	V_{NL}	All types	0,3	V
at High level ($V_{OHB} - V_{IHB}$)	V_{NH}	54LS 64/74/84LS	0,5 0,7	V V

3.2 Associated characteristics

3.2.1 Minimum and maximum values are given for the worst case operation over the ambient temperature range, except for those conditions marked with an asterisk (*)

	54LS	64LS	74LS	84LS	
T _{amb} min.	-55	-40	0	-25	°C
T _{amb} max.	+125	+85	+70	+85	
V _{CC} min.	4,5	4,75			V
V _{CC} max.	5,5	5,25			

3.2.2

Characteristics	Conditions	V _{CC} (V)	Symbol	Min.	Max.	Unit
Total supply current per package	All inputs grounded. All outputs open. Measured after a 4,5V pulse applied to clock. Then grounded	V _{CC} max.	I _{CC}	-	13,0	mA
High level input current	V _{IH(1)} = 7,0V	V _{CC} max.	I _{IH(1)}	-	0,1	mA
	V _{IH(2)} = 2,7V	V _{CC} max.	I _{IH(2)}	-	20,0	µA
Low level input current	V _{IL} = 0,4V	V _{CC} max.	-I _{IL}	-	0,4	mA
Input clamping voltage	-I _{IC} = 18,0mA	V _{CC} min.	-V _{ICA}	-	1,5	V
Output voltage	54LS I _{OH} = -400,0µA	V _{CC} min.	V _{OH}	2,5	-	V
	64/74/84LS I _{OH} = -400,0µA		V _{OH}	2,7	-	V
	All types I _{OL(1)} = 4,0mA (1)		V _{OL(1)}	-	0,4	V
	64/74/84LS I _{OL(2)} = 8,0mA (2)		V _{OL(2)}	-	0,5	V
Output short circuit current	V _{IN} = 0V or 4,5V as appropriate† V _O = 0V (3)	V _{CC} max.	-I _{OS}	15,0	130,0	mA

- (1) Fan out = 10, (2) Fan out = 20,
 (3) Only one output at a time, duration t ≤ 1 sec
 *See 3.2.1 of this specification
 †Refer to truth table

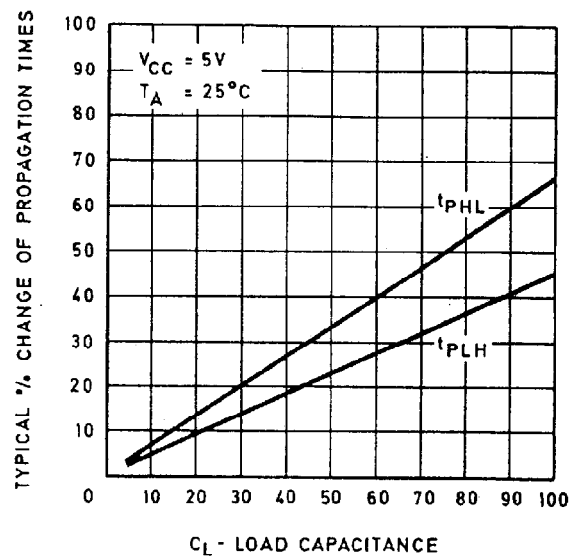
3.2.2

Characteristics	Conditions	$V_{CC}(V)$	Symbol	Min.	Max.	Unit
Propagation times All types	$T_{amb} = 25^{\circ}C$ test conditions as in Sub-group A5	5,0V				
High to Low level			t_{PHL}	-	32,0	ns
Low to High level			t_{PLH}	-	27,0	ns
Maximum pulse widths			t_p	20,0	-	ns
Maximum set-up time	Data		t_{set-up}	25,0	-	ns
	Word select		t_{set-up}	45,0	-	ns
Maximum hold time	Data		t_{hold}	0	-	ns
	Word select		t_{hold}	0	-	ns

*See 3.2.1 of this specification

3.3 Supplementary information

3.3.1 Change of typical propagation time with output loading



Propagation times Vs. load capacitance